

**Search Notes**

Application/Control No.

10/750,926

Examiner

Charles Shedrick

Applicant(s)/Patent under  
Reexamination

LEE, CHANG MUK

Art Unit

2687

**SEARCHED**

Class	Subclass	Date	Examiner
455	575.7	9/15/2005	CS
343	700	9/15/2005	CS
455	90	9/15/2005	CS
343	702	9/15/2005	CS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR